



Product Name : Bluetooth Headset

Model No. : FlyBy

FCC ID. : TQO-HS

Applicant : AiZen Solutions, Inc.

Address : 10F-1, No.29, Puding Rd., Hsinchu 300, Taiwan,

ROC

Date of Receipt : 2005/10/14

Issued Date : 2005/10/21

Report No. : 05AH038-F-R02-T

The test results relate only to the samples tested.

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Test Report Certification

Issued Date : 2005/10/21

Report No. : 05AH038-F-R02-T

QuieTek

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Applicant : AiZen Solutions, Inc.

Address : 10F-1, No.29, Puding Rd., Hsinchu 300, Taiwan, ROC

Manufacturer : AiZen Solutions, Inc.

Model No. : FlyBy

FCC ID. : TQO-HS

Rated Voltage : AC 120 V / 60 Hz

EUT Voltage : USB: DC 5 V, Battery: DC 3.7 V

Trade Name : aizen aizen

Applicable Standard : FCC CFR Title 47 Part 15 Subpart C Section 15.247

Test Result : Complied

The test results relate only to the samples tested.

The test report shall not be reproduced except in full without the written approval of QuieTek Corporation.

Documented By : Carol / sai

(Carol Tsai)

Tested By : Simon Lin

(Simon Lin)

Approved By :

(Bob Fang)



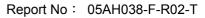
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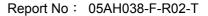
1. General Information

1.1. EUT Description

Product Name	Bluetooth Headset
Trade Name	aizen aizen
Model No.	FlyBy
Frequency Range	2402~2480MHz
Channel Number	79
Type of Modulation	Frequency Hopping Spread Spectrum
Data Speed	Max 723.2kbits/sec
Antenna Gain	0 dBi ±2
Channel Control	Auto
Antenna Type	Printed
USB Cable	Shielded, 1.5m
Power Adapter	LISTED, YFAF22073001

Working F	Working Frequency of Each Channel							
Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency	
Channel 00	2402 MHz	Channel 20	2422 MHz	Channel 40	2442 MHz	Channel 60	2462 MHz	
Channel 01	2403 MHz	Channel 21	2423 MHz	Channel 41	2443 MHz	Channel 61	2463 MHz	
Channel 02	2404 MHz	Channel 22	2424 MHz	Channel 42	2444 MHz	Channel 62	2464 MHz	
Channel 03	2405 MHz	Channel 23	2425 MHz	Channel 43	2445 MHz	Channel 63	2465 MHz	
Channel 04	2406 MHz	Channel 24	2426 MHz	Channel 44	2446 MHz	Channel 64	2466 MHz	
Channel 05	2407 MHz	Channel 25	2427 MHz	Channel 45	2447 MHz	Channel 65	2467 MHz	
Channel 06	2408 MHz	Channel 26	2428 MHz	Channel 46	2448 MHz	Channel 66	2468 MHz	
Channel 07	2409 MHz	Channel 27	2429 MHz	Channel 47	2449 MHz	Channel 67	2469 MHz	
Channel 08	2410 MHz	Channel 28	2430 MHz	Channel 48	2450 MHz	Channel 68	2470 MHz	
Channel 09	2411 MHz	Channel 29	2431 MHz	Channel 49	2451 MHz	Channel 69	2471 MHz	
Channel 10	2412 MHz	Channel 30	2432 MHz	Channel 50	2452 MHz	Channel 70	2472 MHz	
Channel 11	2413 MHz	Channel 31	2433 MHz	Channel 51	2453 MHz	Channel 71	2473 MHz	
Channel 12	2414 MHz	Channel 32	2434 MHz	Channel 52	2454 MHz	Channel 72	2474 MHz	
Channel 13	2415 MHz	Channel 33	2435 MHz	Channel 53	2455 MHz	Channel 73	2475 MHz	
Channel 14	2416 MHz	Channel 34	2436 MHz	Channel 54	2456 MHz	Channel 74	2476 MHz	
Channel 15	2417 MHz	Channel 35	2437 MHz	Channel 55	2457 MHz	Channel 75	2477 MHz	
Channel 16	2418 MHz	Channel 36	2438 MHz	Channel 56	2458 MHz	Channel 76	2478 MHz	
Channel 17	2419 MHz	Channel 37	2439 MHz	Channel 57	2459 MHz	Channel 77	2479 MHz	
Channel 18	2420 MHz	Channel 38	2440 MHz	Channel 58	2460 MHz	Channel 78	2480 MHz	
Channel 19	2421 MHz	Channel 39	2441 MHz	Channel 59	2461 MHz			

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The system receivers have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shift frequencies in synchronization with the transmitted signals Frequency hopping spread spectrum systems are not required to employ all available hopping channels during each transmission. The transmitter is presented with a continuous data stream. In addition, a system employing short transmission bursts must comply with the definition of a frequency hopping system and must distribute its 79 channels and over the minimum number of hopping channels (75 channels).

The incorporation of intelligence within a frequency hopping spread spectrum system that permits the system to recognize other users within the spectrum band so that it individually and independently chooses and adapts its hopsets to avoid hopping on occupied channels is permitted. The coordination of frequency hopping systems in any other manner for the express purpose of avoiding the simultaneous occupancy of individual hopping frequencies by multiple transmitters is not permitted.

Note:

- 1. This device is a Bluetooth Headset included a 2.4GHz receiving function, and 2.4GHz transmitting function.
- 2. These tests were conducted on a sample of the equipment for the purpose of demonstrating compliance with Part 15 Subpart C Paragraph 15.247 for spread spectrum devices.
- 3. Regards to the frequency band operation; the lowest \ middle and highest frequency of channel were selected to perform the test, and then shown on this report.
- 4. This device is a composite device in accordance with Part 15 regulations. The function receiving was measured and made a test report that the report number is 05AH038-F-R01-R under Declaration of Conformity.

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1.2. Operational Description

The EUT is a Bluetooth Headset with 79 channels.

This device is subjected to wireless technology. It is the solution for the seamless integration of Mobile with Bluetooth technology, peripherals (printers, faxes,....), portable handheld devices and PDA.

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1.3. Test Mode

QuieTek has verified the construction and function in typical operation. All the test modes were carried out with the EUT in normal operation, which was shown in this test report and defined as:

Pre-Test Mode				
EMI	Mode 1: Transmit			
Final Test Mode				
EMI	Mode 1: Transmit			

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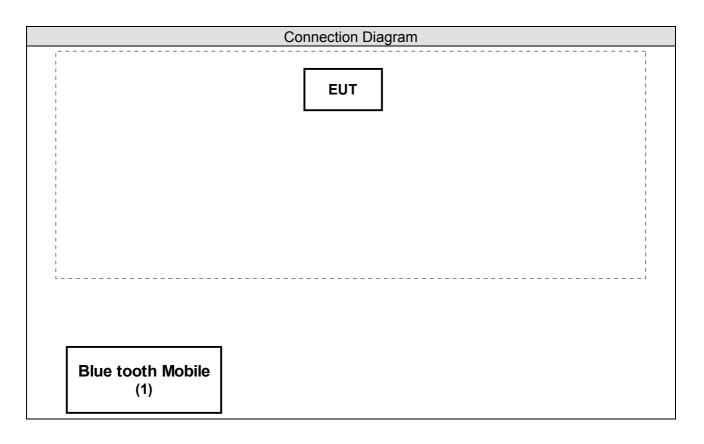


1.4. Tested System Details

The types for all equipments, plus descriptions of all cables used in the tested system (including inserted cards) are:

	Product	Manufacturer	Model No.	Serial No.	FCC ID	Power Cord
1	Blue tooth Mobile	MOTOROLA	V3	00128A8377DE	DoC	

1.5. Configuration of tested System



1.6. EUT Exercise Software

1	Setup the EUT and simulators as shown on 1.5.
2	Enable RF signal and confirm EUT active.
3	Modulate output capacity of EUT up to specification.

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1.7. Test Facility

Ambient conditions in the laboratory:

Items	Test Item	Required (IEC	Actual
		68-1)	
Temperature (°C)	FOO DADT 45 O 45 007	15 - 35	20
Humidity (%RH)	FCC PART 15 C 15.207	25 - 75	50
Barometric pressure (mbar)	Conducted Emission	860 - 1060	950-1000
Temperature (°C)	FOO DADT 45 O 45 047	15 - 35	20
Humidity (%RH)	FCC PART 15 C 15.247	25 - 75	50
Barometric pressure (mbar)	Band Edge (FHSS)	860 - 1060	950-1000
Temperature (°C)	FCC DADT 45 C 45 247	15 - 35	20
Humidity (%RH)	FCC PART 15 C 15.247 Channel Of Number (FHSS)	25 - 75	50
Barometric pressure (mbar)	Chamilei Of Number (FH33)	860 - 1060	950-1000
Temperature (°C)	FCC DADT 45 C 45 247	15 - 35	20
Humidity (%RH)	FCC PART 15 C 15.247	25 - 75	50
Barometric pressure (mbar)	Channel Separation (FHSS)	860 - 1060	950-1000
Temperature (°C)	FCC DADT 45 C 45 247	15 - 35	20
Humidity (%RH)	FCC PART 15 C 15.247	25 - 75	50
Barometric pressure (mbar)	Dwell Time (FHSS)	860 - 1060	950-1000
Temperature (°C)	TOO DADT 15 C 15 247	15 - 35	20
Humidity (%RH)	FCC PART 15 C 15.247 Occupied Bandwidth (FHSS)	25 - 75	50
Barometric pressure (mbar)	Occupied Balluwidili (F1133)	860 - 1060	950-1000
Temperature (°C)	FCC DADT 45 C 45 247	15 - 35	20
Humidity (%RH)	FCC PART 15 C 15.247	25 - 75	50
Barometric pressure (mbar)	Peak Power Output (FHSS)	860 - 1060	950-1000
Temperature (°C)	FOC DADT 45 C 45 047	15 - 35	20
Humidity (%RH)	FCC PART 15 C 15.247	25 - 75	65
Barometric pressure (mbar)	Radiated Emission (FHSS)	860 - 1060	950-1000

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Site Description:

January 24, 2005 File on

Federal Communications Commission

Laboratory Division

7435 Oakland Mills Road

Columbia, MD 21046

Registration Number: 365520

Accredited by CNLA

Accreditation Number: 1313

Effective through: September 27, 2007

Accredited by NVLAP

NVLAP Lab Code: 200347-0

Effective through: September 30, 2006

Site Name: Quietek Corporation

Site Address: No.75-1, Wang-Yeh Valley, Yung-Hsing,

Chiung-Lin, Hsin-Chu County,

Taiwan, R.O.C.

TEL: 886-3-592-8858 / FAX: 886-3-592-8859

E-Mail: service@quietek.com











2. Conducted Emission

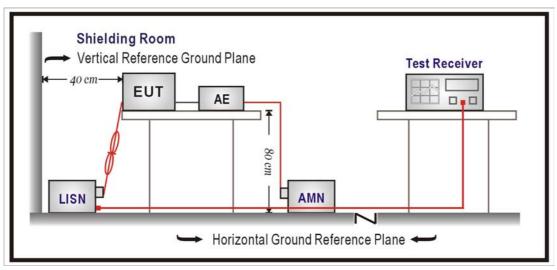
2.1. Test Equipment

The following test equipment are used during the test:

Item	Equipment	Manufacturer	Model No. / Serial No.	Last Cal.	Remark
1	Test Receiver	R&S	ESCS 30/825442/018	Sep., 2005	
2	Artificial Mains Network	R&S	ENV4200/848411/10	Feb., 2005	Peripherals
3	LISN	R&S	ESH3-Z5/825562/002	Feb., 2005	EUT
4	Pulse Limiter	R&S	ESH3-Z2/357.8810.52	Feb., 2005	
5	No.2 Shielded Room			N/A	

Note: All equipment upon which need to calibrated are with calibration period of 1 year.

2.2. Test Setup



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2.3. Limits

FCC Part 15 Subpart C Paragraph 15.207 Limits (dBuV)						
Frequency MHz	QP	AV				
0.15 - 0.50	66-56	56-46				
0.50-5.0	56	46				
5.0 - 30	60	50				

Remarks: In the above table, the tighter limit applies at the band edges.

2.4. Test Procedure

The EUT and simulators are connected to the main power through a line impedance stabilization network (L.I.S.N.). This provides a 50 ohm /50uH coupling impedance for the measuring equipment. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination. (Please refers to the block diagram of the test setup and photographs.)

Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.4: 2003 on conducted measurement.

Conducted emissions were invested over the frequency range from 0.15MHz to 30MHz using a receiver bandwidth of 9kHz.

2.5. Test Specification

According to FCC Part 15 Subpart C Paragraph 15.207: 2004



2.6. Test Result

Product	Bluetooth Headset		
Test Item	Conducted Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/18	Test Site	No.2 Shielded Room

Frequency		Cable	LISN	Reading	Emission	Limits
		Loss	Factor	Level	Level	
	MHz	dB	dB	dBuV	dBuV	dBuV
==:	=======	=====	======	==========	=========	======
Lin	ne 1					
Qu	asi-Peak					
*	0.349	0.10	0.10	44.92	45.12	58.98
	0.490	0.10	0.10	39.37	39.57	56.17
	0.642	0.11	0.10	31.36	31.57	56.00
	1.064	0.11	0.10	37.41	37.62	56.00
	1.908	0.12	0.10	28.14	28.36	56.00
	9.724	0.23	0.39	10.86	11.48	60.00
Αv	erage					
*	0.349	0.10	0.10	33.50	33.70	48.99
	0.490	0.10	0.10	20.80	21.00	46.17
	0.642	0.11	0.10	17.20	17.41	46.00
	1.064	0.11	0.10	21.20	21.41	46.00
	1.908	0.12	0.10	12.60	12.82	46.00
	9.724	0.23	0.39	8.10	8.72	50.00

- 1. All Reading Levels are Quasi-Peak and Average value.
- 2. " * ", means this data is the worst emission level.
- 3. Emission Level = Reading Level + LISN Factor + Cable Loss.



Product	Bluetooth Headset		
Test Item	Conducted Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/18	Test Site	No.2 Shielded Room

	Frequency	Cable Loss	LISN Factor	Reading Level	Emission Level	Limits
	MHz	dB 	dB	dBuV	dBuV	dBuV
	LINE 2					
	Quasi-Peak					
	0.173	0.10	0.10	55.58	55.78	64.79
*	0.361	0.10	0.10	53.09	53.29	58.71
	0.517	0.10	0.10	44.33	44.53	56.00
	0.709	0.11	0.10	42.34	42.55	56.00
	1.275	0.11	0.10	43.77	43.98	56.00
	2.783	0.13	0.15	33.47	33.75	56.00
	Average					
	0.173	0.10	0.10	44.20	44.40	54.82
*	0.361	0.10	0.10	40.70	40.90	48.71
	0.517	0.10	0.10	30.20	30.40	46.00
	0.709	0.11	0.10	26.20	26.41	46.00
	1.275	0.11	0.10	27.80	28.01	46.00
	2.783	0.13	0.15	17.80	18.08	46.00

- 1. All Reading Levels are Quasi-Peak and Average value.
- 2. " * ", means this data is the worst emission level.
- 3. Emission Level = Reading Level + LISN Factor + Cable Loss.



3. Peak Power Output

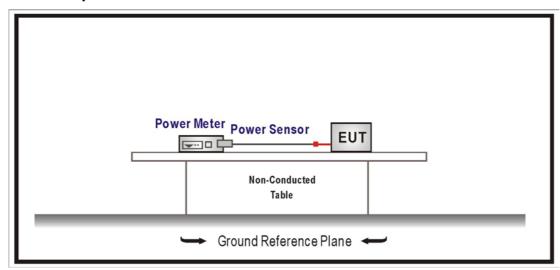
3.1. Test Equipment

The following test equipment are used during the test:

Item	Equipment	Manufacturer	Model No. / Serial No.	Last Cal.
1	Power Meter	Agilent	E4416A / GB41291630	May, 2005
2	Power Sensor	Agilent	E9323A / US40411166	Apr., 2005
3	No.1 OATS			Sep., 2005

Note: All equipment upon which need to calibrated are with calibration period of 1 year.

3.2. Test Setup



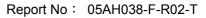
3.3. Limits

For frequency hopping systems operating in the 902-928 MHz band: 1 Watt for systems employing at least 50 hopping channels; and, 0.25 Watts for systems employing less than 50 hopping channels.

For frequency hopping systems in the 2400-2483.5 MHz band employing at least 75 hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1Watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 Watt.

3.4. Test Specification

According to FCC Part 15 Subpart C Paragraph 15.247: 2004





3.5. Test Result

Product	Bluetooth Headset		
Test Item	Peak Power Output		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/19	Test Site	No.1 OATS

Channel No.	Frequency (MHz)	Measure Level (dBm)	Limit (dBm)	Result
00	2402.00	4.40	1Watt = 30 dBm	Pass
39	2441.00	4.98	1Watt= 30 dBm	Pass
78	2480.00	5.26	1Watt= 30 dBm	Pass

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4. Radiated Emission

4.1. Test Equipment

The following test equipment are used during the test:

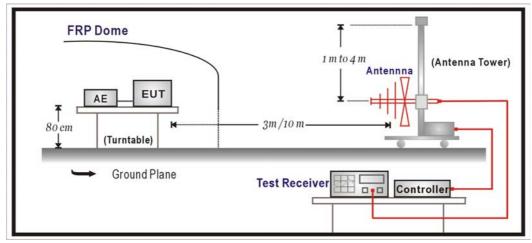
Item	Equipment		Manufacturer	Model No. / Serial No.	Last Cal.
1	X	Test Receiver	R&S	ESCS 30 / 825442/014	Jun., 2005
2	Χ	Spectrum Analyzer	Advantest	R3162 / 91700283	N/A
3	Χ	Pre-Amplifier	Advantest	BB525C / N/A	N/A
4	X	Bilog Antenna	Schaffner	CBL6112B / 2673	Sep., 2005
5	Χ	Spectrum Analyzer	R&S	FSP40 / 100005	Aug., 2005
6	Χ	Pre-Amplifier	HP	8449B / 3008A01123	Feb., 2005
7	Х	Horn Antenna	Schwarzbeck	BBHA 9120D / BBHA9120D312	Jul., 2005
8	No.3	Sep., 2005			

Note: 1. All equipments that need to calibrate are with calibration period of 1 year.

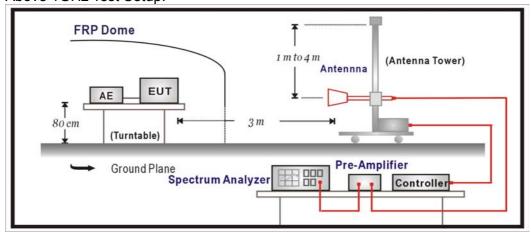
2. Mark "X" test instruments are used to measure the final test results.

4.2. Test Setup

Under 1GHz Test Setup:



Above 1GHz Test Setup:



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4.3. Limits

Emissions radiated outside of the specified frequency bands, except for harmonics, shall be attenuated by at least 20dB below the level of the fundamental or to the general radiated emission limits in paragraph 15.209, whichever is the lesser attenuation.

FCC Part 15 Subpart C Paragraph 15.209 Limits					
Frequency MHz	uV/m	dBuV/m			
30-88	100	40			
88-216	150	43.5			
216-960	200	46			
Above 960	500	54			

Remarks: 1. RF Voltage (dBuV) = 20 log RF Voltage (uV)

- 2. In the Above Table, the tighter limit applies at the band edges.
- 3. Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the device or system.

4.4. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level.

Both horizontal and vertical polarization of the antenna are set on measurement. In order to find the maximum emission, all of the interface cables must be manipulated according to ANSI C63.4:2003 on radiated measurement.

On any frequency or frequencies below or equal to 1000 MHz, the limits shown are based on measuring equipment employing a quasi-peak detector function and on any frequency or frequencies above 1000 MHz the radiated limits shown are based upon the use of measurement instrumentation employing an average detector function. When average radiated emission measurement are included emission measurement below 1000 MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20 dB above the maximum permitted average limit. The bandwidth below 1GHz setting on the field strength meter is 120 kHz and above 1GHz is 1MHz.

4.5. Test Specification

According to FCC Part 15 Subpart C Paragraph 15.247: 2004

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4.6. Test Result

Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

2402MHz

Frequency	Cable	Probe F	PreAMP	Reading	Emission	Margir	n Limit
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
=======	=====	=====	======	======			=======

Horizontal

Peak

4803.900	5.40	29.02	31.71	40.03	42.74	31.26	74.00
7205.600	7.76	31.88	31.93	34.77	42.48	31.52	74.00

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. Receiver setting (Peak Detector): RBW:1MHz; VBW:1MHz; Span:100MHz.
- 3. Receiver setting (AVG Detector): RBW:1MHz; VBW:30Hz; Span:20MHz.
- 4. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.
- 5. The average measurement was not performed when the peak measured data under the limit of average detection. If the readings given are average, peak measurement should also be supplied.
- 6. The other signals were not higher than noise floor, so the further measurement won't be taken.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

Frequency	Cable	Probe PreAMP Reading Emission			Margir	n Limit	
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
=======	=====	:=====:	======	:=====			=======

Vertical

Peak

4804.000	5.40	27.23	31.71	41.31	42.23	31.77	74.00
7206.000	7.76	31.88	31.93	35.56	43.27	30.73	74.00

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. Receiver setting (Peak Detector): RBW:1MHz; VBW:1MHz; Span:100MHz.
- 3. Receiver setting (AVG Detector): RBW:1MHz; VBW:30Hz; Span:20MHz.
- 4. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.
- 5. The average measurement was not performed when the peak measured data under the limit of average detection. If the readings given are average, peak measurement should also be supplied.
- 6. The other signals were not higher than noise floor, so the further measurement won't be taken.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

Frequency	Cable	Probe F	PreAMP	Reading	Emission	Margir	ı Limit
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
=======	=====	=====	=====	======			======

Horizontal

Peak

4885.900	5.49	29.27	31.66	42.50	45.59	28.41	74.00
7326.700	8.33	32.12	31.78	34.48	43.14	30.86	74.00

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. Receiver setting (Peak Detector): RBW:1MHz; VBW:1MHz; Span:100MHz.
- 3. Receiver setting (AVG Detector): RBW:1MHz; VBW:30Hz; Span:20MHz.
- 4. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.
- 5. The average measurement was not performed when the peak measured data under the limit of average detection. If the readings given are average, peak measurement should also be supplied.
- 6. The other signals were not higher than noise floor, so the further measurement won't be taken.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

Frequency	Cable	Probe I	PreAMP	Reading	Emission	Margir	n Limit
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
=======	=====	=====	======	======	=======	=====	=======

Vertical

Peak

4885.700	5.49	27.67	31.66	42.00	43.49	30.51	74.00
7326.700	8.33	32.12	31.78	35.21	43.87	30.13	74.00

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. Receiver setting (Peak Detector): RBW:1MHz; VBW:1MHz; Span:100MHz.
- 3. Receiver setting (AVG Detector): RBW:1MHz; VBW:30Hz; Span:20MHz.
- 4. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.
- 5. The average measurement was not performed when the peak measured data under the limit of average detection. If the readings given are average, peak measurement should also be supplied.
- 6. The other signals were not higher than noise floor, so the further measurement won't be taken.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

Frequency	Cable	Probe F	PreAMP	Reading	Emission	Margir	n Limit
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
=======	=====	=====	=====			=====	======

Horizontal

Peak

4959.800	5.58	29.44	31.63	41.32	44.71	29.29	74.00
7440.000	8.45	32.33	31.55	33.70	42.93	31.07	74.00

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. Receiver setting (Peak Detector): RBW:1MHz; VBW:1MHz; Span:100MHz.
- 3. Receiver setting (AVG Detector): RBW:1MHz; VBW:30Hz; Span:20MHz.
- 4. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.
- 5. The average measurement was not performed when the peak measured data under the limit of average detection. If the readings given are average, peak measurement should also be supplied.
- 6. The other signals were not higher than noise floor, so the further measurement won't be taken.



Product	Bluetooth Headset				
Test Item	Radiated Emission				
Test Mode	Mode 1: Transmit				
Date of Test	2005/10/20	Test S	te	No.3 OATS	

Frequency	Cable	Probe F	PreAMP	Reading	Emission	Margir	n Limit
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
========	=====	======	=====	======	=======	=====	=======

Vertical

Peak

4960.100	5.58	27.97	31.63	42.41	44.33	29.67	74.00
7440.000	8.45	32.33	31.55	34.52	43.75	30.25	74.00

- All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. Receiver setting (Peak Detector): RBW:1MHz; VBW:1MHz; Span:100MHz.
- 3. Receiver setting (AVG Detector): RBW:1MHz; VBW:30Hz; Span:20MHz.
- 4. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.
- 5. The average measurement was not performed when the peak measured data under the limit of average detection. If the readings given are average, peak measurement should also be supplied.
- 6. The other signals were not higher than noise floor, so the further measurement won't be taken.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

Frequency	Cable	Probe I	PreAMP	Margin	Limit		
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
========	=====	:=====	=====	======	======	=====	======
Horizontal							
Quasi-Peak							
255.870	3.33	13.63	0.00	0.65	17.61	28.39	46.00
399.990	4.28	16.72	0.00	1.67	22.67	23.33	46.00
577.360	5.20	18.83	0.00	3.09	27.12	18.88	46.00
718.700	5.94	19.80	0.00	0.66	26.40	19.60	46.00
819.860	6.46	20.43	0.00	2.76	29.64	16.36	46.00
* 939.030	7.08	21.26	0.00	3.15	31.49	14.51	46.00

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. " * ", means this data is the worst emission level.
- 3. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

609.230

739.490

Frequency	Cable	Probe	PreAMF	Reading	Emission	Margin	Limit
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
Vertical	=====	=====	=====	======		=====	======
Quasi-Peak							
45.240	1.30	8.55	0.00	15.27	25.12	14.88	40.00
113.140	1.95	11.88	0.00	8.26	22.09	21.41	43.50
197.670	2.77	9.29	0.00	10.52	22.58	20.92	43.50
365.340	4.09	15.80	0.00	1.01	20.90	25.10	46.00

0.00

0.00

Note:

1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.

0.63

4.95

25.27

31.22

20.73 46.00

14.78 46.00

2. " * ", means this data is the worst emission level.

5.37 19.27

6.05 20.22

3. Emission Level = Reading Level + Probe Factor + Cable Loss – PreAMP.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

F	requency	Cable	Probe F	PreAMP	Reading	Emission	Margin	Limit
		Loss	Factor		Level	Level		
	MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
==	======	=====		=====	=====		=====	
Ho	rizontal							
Qι	ıasi-Peak							
	104.830	1.87	12.33	0.00	3.56	17.76	25.74	43.50
	262.800	3.39	13.59	0.00	0.22	17.20	28.80	46.00
	380.590	4.17	16.38	0.00	1.51	22.06	23.94	46.00
	596.260	5.30	18.93	0.00	5.51	29.74	16.26	46.00
	817.400	6.46	20.43	0.00	2.99	29.87	16.13	46.00
*	897 500	6.87	20.83	0.00	2 99	30.68	15.32	46.00

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. " * ", means this data is the worst emission level.
- 3. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

628.400

937.060

* 763.020 6.17 20.18

Frequency	Cable	Probe I	PreAMP	Margin Limit			
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
Vertical Quasi-Peak			=====				
42.470	1.27	10.51	0.00	13.52	25.30	14.70	40.00
197.480	2.76	9.29	0.00	9.45	21.50	22.00	43.50
415.280	4.35	17.17	0.00	0.33	21.85	24.15	46.00

0.79

5.24

1.79

25.60

31.59

30.90

20.40 46.00

14.41 46.00

15.10 46.00

0.00

0.00

0.00

N	ote	•

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. " * ", means this data is the worst emission level.

5.47 19.34

7.07 22.04

3. Emission Level = Reading Level + Probe Factor + Cable Loss – PreAMP.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.3 OATS

Frequency	Cable	Probe	Probe PreAMP Reading Emission				Limit
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m
=======	=====		=====	======			
Horizontal							
Quasi-Peak							
68.560	1.52	7.76	0.00	3.56	12.85	27.15	40.00
260.260	3.36	13.87	0.00	2.34	19.58	26.42	46.00
380.600	4.17	16.38	0.00	3.10	23.65	22.35	46.00
551.600	5.06	19.01	0.00	1.88	25.95	20.05	46.00
667.430	5.67	18.98	0.00	1.33	25.98	20.02	46.00
* 853.280	6.64	20.86	0.00	3.15	30.65	15.35	46.00

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. " * ", means this data is the worst emission level.
- 3. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.



Product	Bluetooth Headset		
Test Item	Radiated Emission		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/21	Test Site	No.3 OATS

Frequency	Cable	Probe PreAMP Reading Emission			Margir	ı Limit	
	Loss	Factor		Level	Level		
MHz	dB	dB/m	dB	dBuV	dBuV/m	dB	dBuV/m

Vertical

Quasi-Peak

*	42.650	1.27	10.51	0.00	20.62	32.40	7.60	40.00
	201.620	2.80	9.75	0.00	10.10	22.65	20.85	43.50
	368.500	4.11	15.75	0.00	3.28	23.14	22.86	46.00
	406.580	4.31	16.83	0.00	0.33	21.47	24.53	46.00
	544.700	5.03	18.86	0.00	1.79	25.68	20.32	46.00
	740.840	6.05	20.22	0.00	4.99	31.26	14.74	46.00

- 1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
- 2. " * ", means this data is the worst emission level.
- 3. Emission Level = Reading Level + Probe Factor + Cable Loss PreAMP.



5. Band Edge

5.1. Test Equipment

The following test equipment are used during the test:

RF C	RF Conducted Measurement:								
Item	Equip	oment	Manufacturer	Model No. / Serial No.	Last Cal.				
1	Spec	trum Analyzer	R&S	FSP / 100561	Mar., 2005				
2	No.1	OATS		•	Sep., 2005				
RF R	adiate	d Measurement:							
Item		Equipment	Manufacturer	Model No. / Serial No.	Last Cal.				
1	Х	Spectrum Analyzer	R&S	FSP40 / 100005	Aug., 2005				
2	Х	Pre-Amplifier	HP	8449B / 3008A01123	Feb., 2005				
3		Loop Antenna	R&S	HFH2-Z2 / 833799/004	Sep., 2005				
4		BiconiLog Antenna	Schwarzbeck	VULB 9166 / 1061	Sep., 2005				
5		Bilog Antenna	Chase	CBL6112B / 2455	Sep., 2005				
6	Х	Horn Antenna	Schwarzbeck	BBHA 9120D / BBHA9120D312	Sep., 2005				
7	No.1	No.1 OATS							

Note: 1. All equipments that need to calibrate are with calibration period of 1 year.

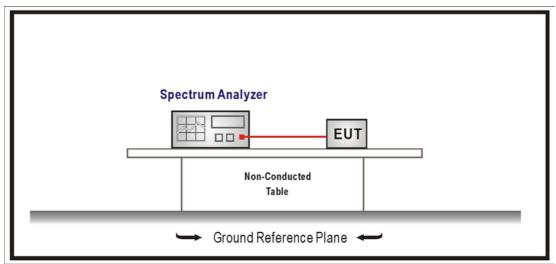
2. Mark "X" test instruments are used to measure the final test results.

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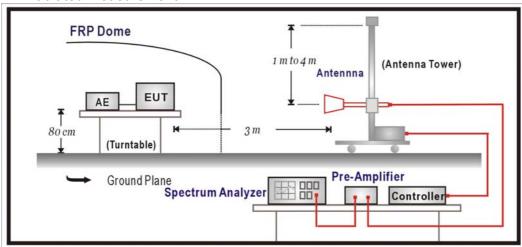


5.2. Test Setup

RF Conducted Measurement:



RF Radiated Measurement:





5.3. Limits

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 15.205(c)).

5.4. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT was positioned such that the distance from antenna to the EUT was 3 meters.

The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level.

Both horizontal and vertical polarization of the antenna are set on measurement. In order to find the maximum emission, all of the interface cables must be manipulated according to ANSI C63.4:2003 on radiated measurement.

The bandwidth below 1GHz setting on the field strength meter is 120 kHz, above 1GHz are 1 MHz.

5.5. Test Specification

According to FCC Part 15 Subpart C Paragraph 15.247: 2004

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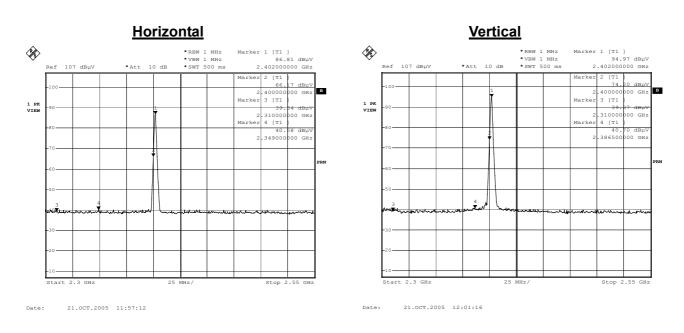


5.6. Test Result

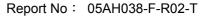
Product	Bluetooth Headset		
Test Item	Band Edge		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/21	Test Site	No.1 OATS

RF Radiated Measurement: (Peak Detector)

				<i></i>				
	Frequency	Reading	Probe	Cable	PreAMP	Emission	Limit	
Channel No.		Level	Factor	Loss	(dB)	Level	(dBuV/m)	Result
	(MHz)	(dBuV)	(dB/m)	(dB)	(ub)	(dBuV/m)	(ubuv/iii)	
00(Horizontal)	2349.000	40.08	24.33	3.91	0.00	36.63	74	Pass
00(Vertical)	2386.500	40.70	22.90	3.92	0.00	35.85	74	Pass



Note: The average measurement was not performed when the peak measured data under the limit of average detection. If the readings given are average, peak measurement should also be supplied.

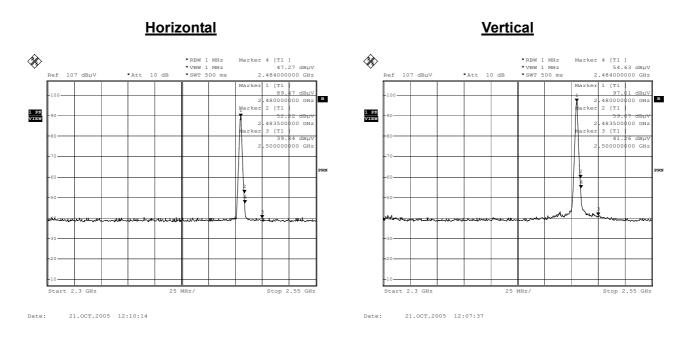




Product	Bluetooth Headset		
Test Item	Band Edge		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/21	Test Site	No.1 OATS

RF Radiated Measurement: (Peak Detector)

1		•		<u> </u>	1		1	
Channel No. I	Frequency	Reading	Probe	Cable	PreAMP	Emission	Limit	
	(MHz)	Level	Factor	Loss		Level	(dBuV/m)	Result
	(IVI⊟Z)	(dBuV)	(dB/m)	(dB)	(dB)	(dBuV/m)	(ubu v/III)	
78(Horizontal)	2484.000	47.27	24.69	4.00	0.00	44.35	74	Pass
78(Vertical)	2484.000	54.63	23.09	4.00	0.00	50.11	74	Pass



Note: The average measurement was not performed when the peak measured data under the limit of average detection. If the readings given are average, peak measurement should also be supplied.



6. Channel of Number

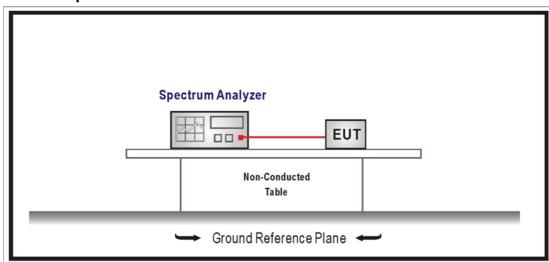
6.1. Test Equipment

The following test equipment are used during the test:

Item	Equipment	Manufacturer	Model No. / Serial No.	Last Cal.
1	Spectrum Analyzer	R&S	FSP / 100561	Mar., 2005
2	No.1 OATS			Sep., 2005

Note: 1. All equipments that need to calibrate are with calibration period of 1 year.

6.2. Test Setup



6.3. Limits

For frequency hopping systems operating in the 902-928 MHz band: if the 20 dB bandwidth of the hopping channel is less than 250 kHz, the system shall use at least 50 hopping frequencies and the average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 20 second period; if the 20 dB bandwidth of the hopping channel is 250 kHz or greater, the system shall use at least 25 hopping frequencies and the average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 10 second period. The maximum allowed 20 dB bandwidth of the hopping channel is 500 kHz.

For frequency hopping systems operating in the 2400-2483.5 MHz bands, which use fewer than 75 hopping frequencies, may employ intelligent hopping techniques to avoid interference to other transmissions. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 non-overlapping channels are used.

For frequency hopping systems operating in the 5725-5850 MHz band shall use at least 75 hopping frequencies.

6.4. Test Specification

According to FCC Part 15 Subpart C Paragraph 15.247: 2004

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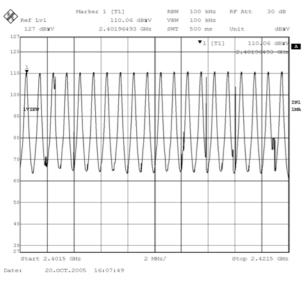


6.5. Test Result

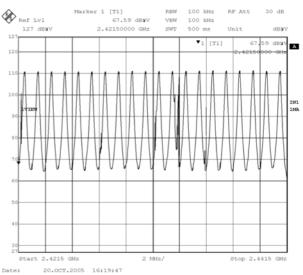
Product	Bluetooth Headset		
Test Item	Channel of Number		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.1 OATS

Frequency Range (MHz)	Measure Level (Hopping Channel)	Limit (Hopping Channel)	Result
2402 ~ 2480	79	>75	Pass

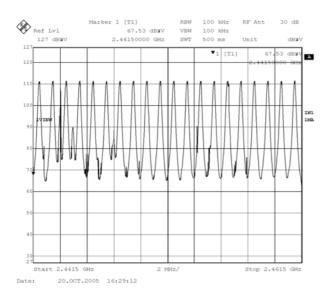
2402-2420MHz



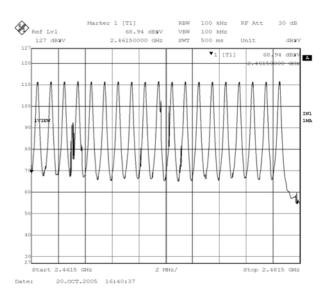
2421-2440MHz



2440-2461MHz



2461-2480MHz





7. Channel Separation

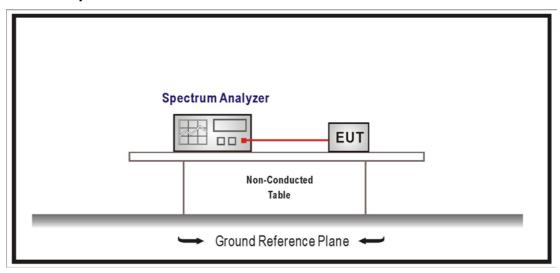
7.1. Test Equipment

The following test equipment are used during the test:

Item	Equipment	Manufacturer	Model No. / Serial No.	Last Cal.
1	Spectrum Analyzer	R&S	FSP / 100561	Mar., 2005
2	No.1 OATS			Sep., 2005

Note: 1. All equipments that need to calibrate are with calibration period of 1 year.

7.2. Test Setup



7.3. Limits

For frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

7.4. Test Specification

According to FCC Part 15 Subpart C Paragraph 15.247: 2004



7.5. Test Result

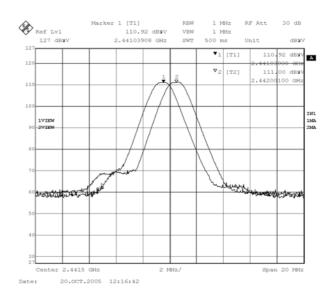
Product	Bluetooth Headset		
Test Item	Channel Separation		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/20	Test Site	No.1 OATS

Channel No.	Frequency (MHz)	Measure Level (kHz)	Result
00	2402.00	1000	Pass
39	2441.00	1000	Pass
78	2480.00	1000	Pass

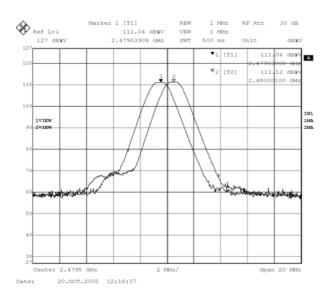
Channel 00

Marker 1 [T1] RBN 1 M91z RF Att 30 dB 110.11 dByV VBN 1 M91z 127 dByV 2.40202004 GHz SWT 500 ms Unit dByV 127 120 V1 [T1] 110.11 dByV V2 [T2] 110.11 dByV V2 [T2] 110.11 dByV V2 [T2] 110.11 dByV V2 [T2] 110.12 dByV 2.4030 d212 GHz 110.12 dByV 2.4030 d212

Channel 39



Channel 78





8. Occupied Bandwidth

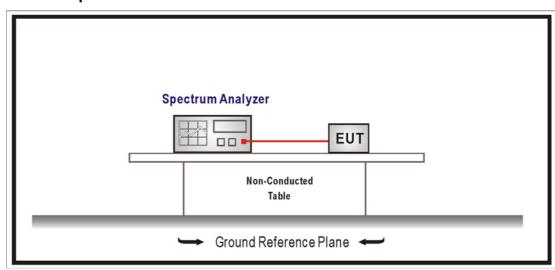
8.1. Test Equipment

The following test equipment are used during the test:

Item	Equipment	Manufacturer	Model No. / Serial No.	Last Cal.
1	Spectrum Analyzer	R&S	FSP / 100561	Mar., 2005
2	No.1 OATS			Sep., 2005

Note: 1. All equipments that need to calibrate are with calibration period of 1 year.

8.2. Test Setup



8.3. Limits

For frequency hopping systems operating in the 902-928 MHz band: if the 20 dB bandwidth of the hopping channel is less than 250 kHz, the system shall use at least 50 hopping frequencies and the average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 20 second period; if the 20 dB bandwidth of the hopping channel is 250 kHz or greater, the system shall use at least 25 hopping frequencies and the average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 10 second period. The maximum allowed 20 dB bandwidth of the hopping channel is 500 kHz.

For frequency hopping systems operating in the 5725-5850 MHz bands. The maximum 20 dB bandwidth of the hopping channel is 1 MHz.

For frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

8.4. Test Specification

According to FCC Part 15 Subpart C Paragraph 15.247: 2004

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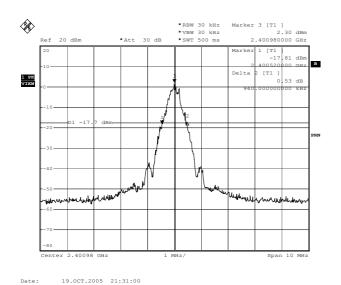
8.5. Test Result

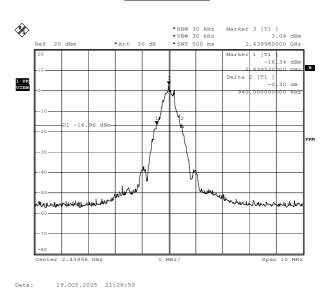
Product	Bluetooth Headset		
Test Item	Occupied Bandwidth		
Test Mode	Mode 1: Transmit		
Date of Test	2005/10/19	Test Site	No.1 OATS

Channel No.	Frequency (MHz)	Measure Level (kHz)	Result
00	2402.00	940	Pass
39	2441.00	940	Pass
78	2480.00	920	Pass

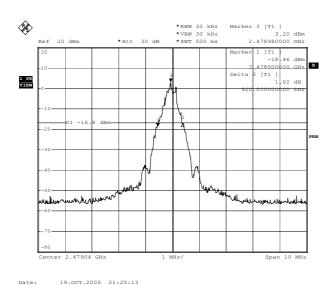
Channel 00

Channel 39





Channel 78



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9. Dwell Time

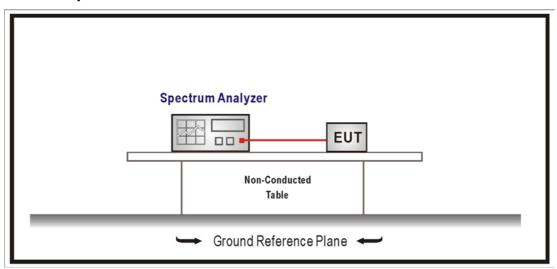
9.1. Test Equipment

The following test equipment are used during the test:

Item	Equipment	Manufacturer	Model No. / Serial No.	Last Cal.
1	Spectrum Analyzer	R&S	FSP / 100561	Mar., 2005
2	No.1 OATS			Sep., 2005

Note: 1. All equipments that need to calibrate are with calibration period of 1 year.

9.2. Test Setup



9.3. Limits

For frequency hopping systems operating in the 902-928 MHz band: if the 20 dB bandwidth of the hopping channel is less than 250 kHz, the system shall use at least 50 hopping frequencies and the average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 20 second period; if the 20 dB bandwidth of the hopping channel is 250 kHz or greater, the system shall use at least 25 hopping frequencies and the average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 10 second period. For frequency hopping systems operating in the 2400-2483.5 MHz bands. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

For frequency hopping systems operating in the 5725-5850 MHz bands. The average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 30 second period.

9.4. Test Specification

According to FCC Part 15 Subpart C Paragraph 15.247: 2004



9.5. Test Result

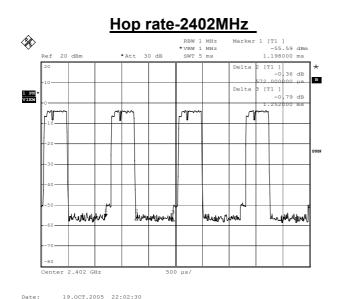
Product	Bluetooth Headset		
Test Item	Dwell Time		
Test Mode	Mode 1: Transmit –DH1		
Date of Test	2005/10/19	Test Site	No.1 OATS

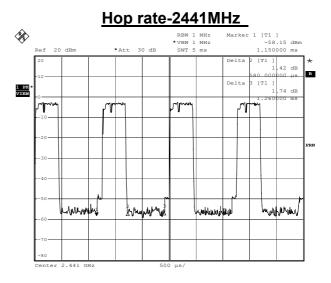
Occupancy Time of Frequency Hopping System

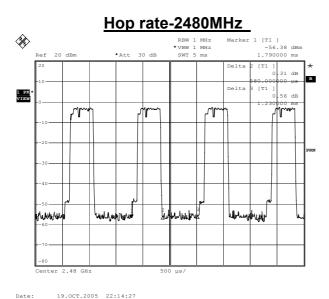
Test Time Period: 0.4*79=31.6sec , Hopping Times Within 1sec: 40/50msec=0.8=800 /sec

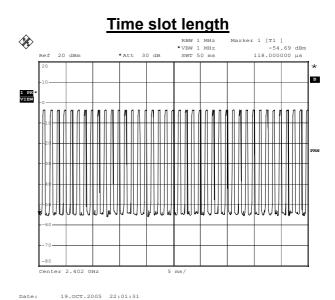
- A) 2402MHz The Maximum Occupancy Time Within 31.6sec: (572 μ s*800)/(79*31.6)=183.304msec \circ
- B) 2441MHz The Maximum Occupancy Time Within 31.6sec: (580 μ s*800)/(79*31.6)=185.868msec \circ
- C) 2480MHz The Maximum Occupancy Time Within 31.6sec: (580 μ s*800)/(79*31.6)=185.868msec \circ

Test Result: The Average Occupancy Time of Each Highest $\,^{,}$ Middle and Lowest Channel Is Less Than 0.4sec $\,^{,}$ And Corresponds to The Standard $\,^{,}$









Note: Dwell time=time slot length * hop rate / number of hopping channels * period

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Product	Bluetooth Headset		
Test Item	Dwell Time		
Test Mode	Mode 1: Transmit –DH3		
Date of Test	2005/10/19	Test Site	No.1 OATS

Occupancy Time of Frequency Hopping System

Test Time Period: 0.4*79=31.6sec , Hopping Times Within 1sec: 20/50msec=0.4=400 /sec

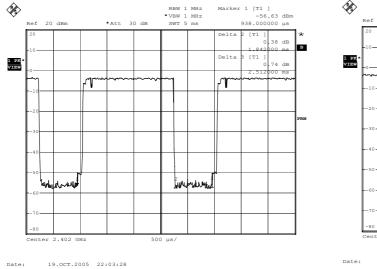
- A) 2402MHz The Maximum Occupancy Time Within 31.6sec: $(1842 \mu s*400)/(79*31.6)=295.145msec$
- B) 2441MHz The Maximum Occupancy Time Within 31.6sec: $(1840 \,\mu\,\text{s*}400)/(79*31.6)=294.482\text{msec}$
- C) 2480MHz The Maximum Occupancy Time Within 31.6sec: (1830 μ s*400)/(79*31.6)=293.222msec \circ

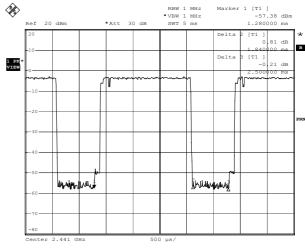
Test Result: The Average Occupancy Time of Each Highest, Middle and Lowest Channel Is Less Than

0.4sec , And Corresponds to The Standard .

Hop rate-2402MHz

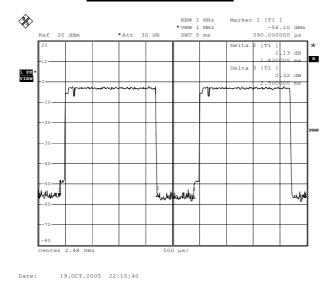
Hop rate-2441MHz

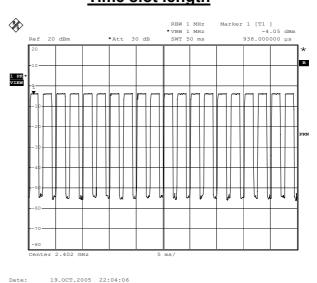




Hop rate-2480MHz

Time slot length





Note: Dwell time = time slot length * hop rate / number of hopping channels * period



Product	Bluetooth Headset		
Test Item	Dwell Time		
Test Mode	Mode 1: Transmit –DH5		
Date of Test	2005/10/21	Test Site	No.1 OATS

Occupancy Time of Frequency Hopping System

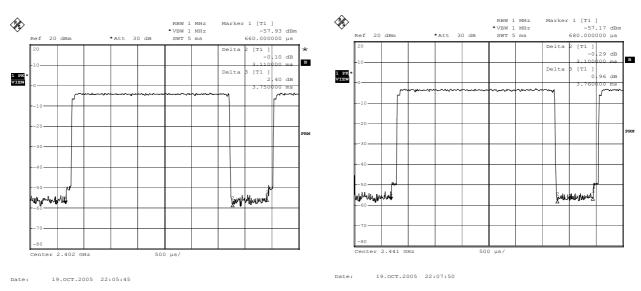
Test Time Period: 0.4*79=31.6sec , Hopping Times Within 1sec: 13/50msec=0.26=260 /sec

- A) 2402MHz The Maximum Occupancy Time Within 31.6sec: $(3110 \mu s*260)/(79*31.6)=323.906msec$
- B) 2441MHz The Maximum Occupancy Time Within 31.6sec: $(3100 \mu s*260)/(79*31.6)=322.865msec$
- C) 2480MHz The Maximum Occupancy Time Within 31.6sec: (3090 μ s*260)/(79*31.6)=321.823msec \circ

Test Result: The Average Occupancy Time of Each Highest $\,^{,}$ Middle and Lowest Channel Is Less Than 0.4sec $\,^{,}$ And Corresponds to The Standard $\,^{,}$

Hop rate-2402MHz

Hop rate-2441MHz



Hop rate-2480MHz

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Note: Dwell time = time slot length * hop rate / number of hopping channels * period

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Time slot length

